

<b>Notice of References Cited</b>		Application/Control No. 10/564,491	Applicant(s)/Patent Under Reexamination DEGEL ET AL.	
		Examiner Dwan A. Gerido, Ph.D.	Art Unit 1797	Page 1 of 1

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	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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